


<b>Search Notes</b>  	<b>Application/Control No.</b>  10607119	<b>Applicant(s)/Patent Under Reexamination</b>  VADELLA ET AL.
	<b>Examiner</b>  Anya, Charles E	<b>Art Unit</b>  2194

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
conferenced with Wei Zhen and William Thomson <i>WP</i>	11/28/07	ca <i>VF</i>

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner